# **TELECOMMUNICATION SYSTEM SECONDARY PROTECTION**

Ion-Implanted Breakdown Region
 Precise and Stable Voltage
 Low Voltage Overshoot under Surge

DEVICE	Vorse	V <sub>(80)</sub>
'3240F3	180	240
'3260F3	200	260
'3290F3	220	290
'3320F3	240	320
3380F3	270	380

- Planar Passivated Junctions
   Low Off-State Current < 10 μA</li>
- Rated for International Surge Wave Shapes

WAVE SHAPE	STANDARD	ITSP A
2/10 µs	FCC Part 68	175
8/20 µs	ANSI C62.41	120
10/160 µs	FCC Part 68	60
10/580 µs	FCC Part 88	45
0.5/700 µs	RLM 88	38
	FTZ R12	50
10/700 µs	VDE 0433	50
	CCITT IX K17/K20	50
10/1000 µs	REA PE-60	35

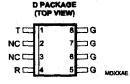
# Surface Mount and Through-Hole Options

PACKAGE	PART # SUFFIX
Small-outline	D
Small-outline taped and reeled	DR
Plastic DIP	P
Single-in-line	SŁ

# UL Recognized, E132482

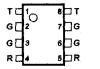
### description

These high voltage dual symmetrical transient voltage suppressor devices are designed to protect telecommunication applications with ground backed ringing against transients caused by lightning strikes and a.c. power lines. Offered in five voltage variants to meet battery and protection requirements they are guaranteed to suppress and withstand the listed international lightning surges in both polarities. Transients are initially clipped by breakdown clamping until the voltage rises to the breakover level, which



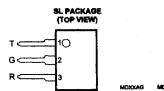
NC - No internal connection

# P PACKAGE (TOP VIEW)

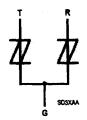


Specified T terminal ratings require connection of pins 1 and 8. Specified R terminal ratings require connection of pins 4 and 5.

MOXXAF



# device symbol



Terminals T, R and G correspond to the alternative line designators of A, B and C

causes the device to crowbar. The high crowbar holding current prevents d.c. latchup as the current subsides.

These monolithic protection devices are fabricated in ion-implanted planar structures to

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# description (Continued)

ensure precise and matched breakover control and are virtually transparent to the system in normal operation

The small-outline 8 pin assignment has been carefully chosen for the TISP series to maximise the inter-pin clearance and creepage distances which are used by standards (e.g. IEC950) to establish voltage withstand ratings.

# absolute maximum ratings

RATING		SYMBOL	VALUE	UNIT
	'3240F3		± 180	<del> </del>
	'3260F3		± 200	1
Repetitive peak off-state voltage (0°C < T <sub>J</sub> < 70°C)	'3290F3	VORM	± 220	V
	'3320F3		± 240	
	'3380F3		± 270	1
Non-repetitive peak on-state pulse current (see Notes 1, 2 and 3)				<del></del>
1/2 µs (Gas tube differential transient, open-circuit voltage wave	shape 1/2 µs)		350	
2/10 µs (FCC Part 68, open-circuit voltage wave shape 2/10 µs	)		175	
8/20 µs (ANSI C62.41, open-circuit voltage wave shape 1.2/50	he)		120	ł
10/160 µs (FCC Part 68, open-circuit voltage wave shape 10/16	30 µs)	-	60	1
5/200 µs (VDE 0433, open-circuit voltage wave shape 2 kV, 10/	/700 μs)	ITSP	50	A
0.5/310 µs. (RLM 88, open-circuit voltage wave shape 1.5 kV, 0.	.5/700 µs)		38	ļ
5/310 µs (CCITT IX K17/K20, open-circuit voltage wave shape	2 kV, 10/700 µs)		50	
5/310 µs (FTZ R12, open-circuit voltage wave shape 2 kV, 10/7	00 μs)		50	
10/560 µs. (FCC Part 68, open-circuit voltage wave shape 10/56	50 μs)		45	
10/1000 µs (REA PE-60, open-circuit voltage wave shape 10/10	000 µs)	-	35	
Non-repetitive peak on-state current (see Notes 2 and 3)	D Package	· <del></del>	4	<del> </del>
50 Hz, 1 s	P Package	1 <sub>TSM</sub>	6	A ms
	SL Package		6	
initial rate of rise of on-state current, Linear current ramp, Maximum ramp value < 38 A			250	A/µs
Junction temperature		Tu	-40 to +150	°C
Storage temperature range		Teta	-40 to +150	°C

- NOTES: 1. Further details on surge wave shapes are contained in the Applications Information section.
  - Initially the TISP must be in thermal equilibrium with 0°C < T<sub>J</sub> <70°C. The surge may be repeated after the TISP returns to its initial conditions.
  - 3. Above 70°C, derate linearly to zero at 150°C lead temperature.

# electrical characteristics for the T and R terminals, T<sub>J</sub> = 25°C

	PARAMETER	TEST CONDITIONS	TISPS	240F3	TISPS	260F3	TISPS	290F3	UNIT
	PARAMETER	IESI COMPITIONS	MIN	MIN MAX		MAX	MIN M	MAX	UPHI
IDRM	Repetitive peak off- state current	V <sub>D</sub> = ±2V <sub>DRM</sub> , 0°C < T <sub>J</sub> < 70°C		±10		±10		±10	μΑ
lo	Off-state current	V <sub>D</sub> = ±50 V		±10		±10		±10	μA
^	Off-state capacitance	1 = 100 kHz, V <sub>d</sub> = 100 mV O Package V <sub>D</sub> = 0, (see Notes 4 and 5) P Package	50† 65†	150 200	50† 65†	150 200	50† 65†	150 200	fF
Coff	On-state capacitance	V <sub>D</sub> = 0, (see Notes 4 and 5) P Package Third terminal = -50 to +50 V SL Package	30†	100	30†	100	30†	100	11

- NOTES: 4. These capacitance measurements employ a three terminal capacitance bridge incorporating a guard circuit. The third terminal is connected to the guard terminal of the bridge.
  - 5. Further details on capacitance are given in the Applications Information section.

<sup>†</sup> Typical value of the parameter, not a limit value.

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# electrical characteristics for the T and G or the R and G terminals, T<sub>J</sub> = 25°C

-	PARAMETER	TEST CONDITIONS	TISP3	240F3	TISPS	260F3	TISP3	290F3	UNIT
	Charles of Part	1201 COMDITIONS	MIN	MAX	MIN	MAX	MIN	MAX	UNI
IDRM	Repetitive peak off- state current	$V_D = \pm V_{DRM}, 0^{\circ}C < T_J < 70^{\circ}C$		±10		±10		±10	μΑ
V <sub>(BO)</sub>	Breakover voltage	dv/dt = ±250 V/ms, Source Resistance = 300 Ω		±240		±260		±290	٧
V <sub>(BO)</sub>	Impulse breakover volt- age	dv/dt = ±1000 V/μs, dt/dt < 20 A/μs Source Resistence = 50 Ω		±267†		±287†		±317†	٧
I <sub>(BO)</sub>	Breakover current	dv/dt = ±250 V/ms, Source Resistance = 300 Ω	±0.15	±0.6	±0.15	±0.6	±0.15	±0.6	A
V <sub>T</sub>	On-state voltage	I <sub>7</sub> = ±5 A, I <sub>W</sub> = 100 μs		±3		±3	-	±3	V
I <sub>H</sub>	Holding current	dVdt = -/+30 mA/ms	±0.15		±0.15		±0.15		A
dv/dt	Critical rate of rise of off-state voltage	Linear voltage ramp,  Maximum ramp value < 0.85V <sub>(BR)MIN</sub>	±5		±5		±5		kV/µs
l <sub>D</sub>	Off-state current	V <sub>D</sub> = ±50 V		±10		±10		±10	μA
		$f = 100 \text{ kHz}, V_d = 100 \text{ mV} V_D = 0,$	57†	95	57†	95	57†	95	pF
Coff	Off-state capacitance	Third terminal = -50 to +50 V V <sub>D</sub> = -5 V	26†	45	26†	45	26†	45	pF
		(see Notes 6 and 7) V <sub>D</sub> ≈ -50 V	11†	20	11†	20	111	20	pF

NOTES: 6 These capacitance measurements employ a three terminal capacitance bridge incorporating a guard circuit. The third terminal is connected to the guard terminal of the bridge.

# electrical characteristics for the T and R terminals, $T_J = 25$ °C

	PARAMETER TEST CONDITIONS			TISPS	320F3	TISPS	380F3	UNIT
	PANAMETEN	(ES) COMPINOIS	TEST CONDITIONS		MAX	MIN	MAX	ONL
IDRM	Repetitive peak off- state current	V <sub>D</sub> = ±V <sub>DRM</sub> , 0°C < T <sub>J</sub> < 70°C	i		±10		±10	μΑ
D	Off-state current	V <sub>D</sub> = ±50 V			±10		±10	μΑ
		f = 100 kHz, V <sub>d</sub> = 100 mV	D Package	50†	150	50†	150	
Coff	Off-state capacitance	V <sub>D</sub> = 0, (see Notes 4 and 5)	P Package	65†	200	65†	200	fF
		Third terminal = -50 to +50 V	St. Package	30†	100	30↑	100	

NOTES: 4. These capacitance measurements employ a three terminal capacitance bridge incorporating a guard circuit. The third terminal is connected to the guard terminal of the bridge.

# electrical characteristics for the T and G or the R and G terminals, $T_J = 25^{\circ}C$

		TEST CONDITIONS	TISP	TISPS	UNIT		
	PARAMETER	(ES) CONDITIONS	MIN	MIN MAX		MIN MAX	
l <sub>DRM</sub>	Repetitive peak off- state current	$V_D = \pm V_{DRM}, 0^{\circ}C < T_J < 70^{\circ}C$		±10		±10	μA
V <sub>(BO)</sub>	Breakover voltage	dv/dt = ±250 V/ms, Source Resistance = 300 Ω		±320		±380	٧
V <sub>(BO)</sub>	Impulse breakover voit- age	dv/dt ≈ ±1000 V/μs, di/dt < 20 A/μs Source Resistance = 50 Ω		±347†		±407†	ν



<sup>7.</sup> Further details on capacitance are given in the Applications information section

<sup>†</sup> Typical value of the parameter, not a limit value.

<sup>5.</sup> Further details on capacitance are given in the Applications information section.

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# electrical characteristics for the T and G or the R and G terminals, T<sub>.1</sub> = 25°C (Continued)

	PARAMETER	TEST CONDITIONS		TISPI	320F3	TISPS	380F3	UNIT
	PANAMETER	I EST CORDITIONS		MIN	MAX	Mile	MAX	UNIT
(BO)	Breakover current	dv/df ± ±250 V/ms, Source Resistance = 300 Ω		±0.15	±0.6	±0.15	±0.6	A
Vr	On-state voltage	l <sub>T</sub> = ±5 A, t <sub>W</sub> = 100 μs			±3		±3	V
I <sub>H</sub>	Holding current	dl/dt = -/+30 mA/ms		±0.15		±0.15		A
dv/dt	Critical rate of rise of off-state voltage	Linear voltage ramp,  Maximum ramp value < 0.85V <sub>(BR)MIN</sub>		<b>±</b> 5		±5		kV/µs
T <sub>D</sub>	Off-state current	V <sub>D</sub> = ±50 V		7.	±10		±10	μA
		f = 100 kHz, V <sub>d</sub> = 100 mV	V <sub>D</sub> ≈ 0,	57†	95	57†	95	ρF
Coff	Off-state capacitance	Third voltage = -50 to +50 V	V <sub>D</sub> ≈ -5 V	26†	45	26†	45	pF
		(see Notes 6 and 7)	V <sub>D</sub> ≠ -50 V	11†	20	117	20	ρF

NOTES: 6 These capacitance measurements employ a three terminal capacitance bridge incorporating a guard circuit. The third terminal is connected to the guard terminal of the bridge.

# PARAMETER MEASUREMENT INFORMATION Quadrant I Switching Characteristic Vano Vano

Figure 1. VOLTAGE-CURRENT CHARACTERISTIC FOR ANY PAIR OF TERMINALS

<sup>7.</sup> Further details on capacitance are given in the Applications Information section.

<sup>†</sup> Typical value of the parameter, not a limit value.

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# thermal characteristics

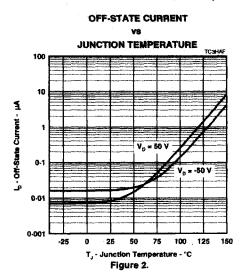
PARAMETER			TYP	MAX	UNIT
	D Package			160	
R <sub>BJA</sub> Junction to free air thermal resistance	P Package			100	°C/W
	SL Package			105	

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# TYPICAL CHARACTERISTICS T and G, or R and G terminals

0.9 -25

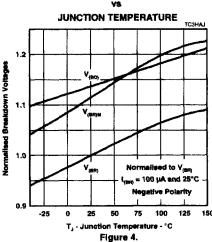
0 25 50 75 100



# **JUNCTION TEMPERATURE** 1.2 Normalised Bresidown Voltage Normalised to V<sub>grito</sub> = 100 μA and 25°C **Positive Polarity**

NORMALISED BREAKDOWN VOLTAGES

# **NORMALISED BREAKDOWN VOLTAGES**

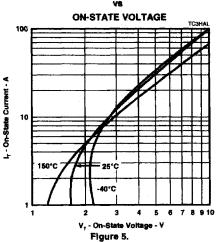


# **ON-STATE CURRENT**

T<sub>a</sub> - Junction Temperature - °C

Figure 3.

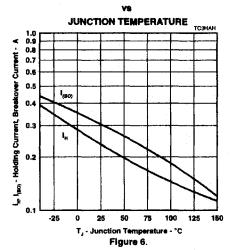
125 150



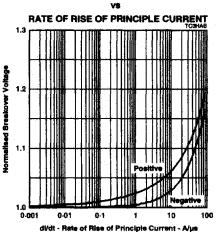
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# TYPICAL CHARACTERISTICS T and G, or R and G terminals

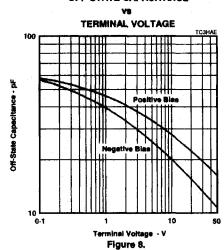
# **HOLDING CURRENT & BREAKOVER CURRENT**



# NORMALISED BREAKOVER VOLTAGE

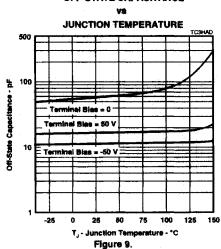


# **OFF-STATE CAPACITANCE**



# **OFF-STATE CAPACITANCE**

Figure 7.





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# TYPICAL CHARACTERISTICS T and G, or R and G terminals

# SURGE CURRENT

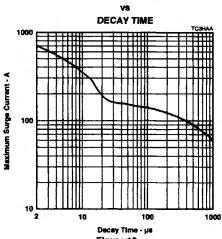
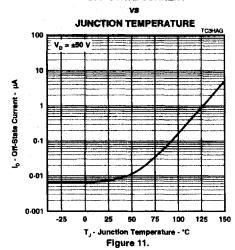


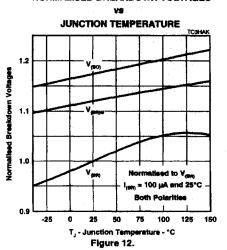
Figure 10.

# TYPICAL CHARACTERISTICS T and R terminals

# **OFF-STATE CURRENT**

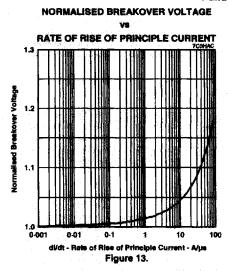
# NORMALISED BREAKDOWN VOLTAGES

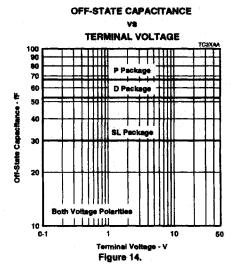




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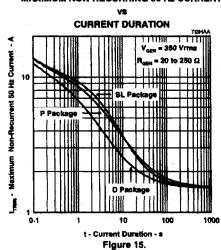
# TYPICAL CHARACTERISTICS T and R terminals

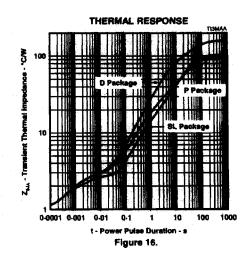




# THERMAL INFORMATION

# **MAXIMUM NON-RECURRING 50 Hz CURRENT**







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# **APPLICATIONS INFORMATION**

# electrical characteristics

The electrical characteristics of a TISP are strongly dependent on junction temperature,  $T_J$ . Hence a characteristic value will depend on the junction temperature at the instant of measurement. The values given in this data sheet were measured on commercial testers, which generally minimise the temperature rise caused by testing. Application values may be calculated from the parameters' temperature curves, the power dissipated and the thermal response curve ( $Z_\theta$ ).

# lightning surge

# wave shape notation

Most lightning tests, used for equipment verification, specify a unidirectional sawtooth waveform which has an exponential rise and an exponential decay. Wave shapes are classified in terms of peak amplitude (voltage or current), rise time and a decay time to 50% of the maximum amplitude. The notation used for the wave shape is amplitude, rise time/decay time. A 50A, 5/310 µs wave shape would have a peak current value of 50 A, a rise time of 5 µs and a decay time of 310 µs. The TISP surge current graph comprehends the wave shapes of commonly used surges.

### generators

There are three categories of surge generator type, single wave shape, combination wave shape and circuit defined. Single wave shape generators have essentially the same wave shape for the open circuit voltage and short circuit current). Combination generators have two wave shapes, one for the open circuit voltage and short circuit current). Combination generators have two wave shapes, one for the open circuit voltage and the other for the short circuit current (e.g. 1.2/50 µs open circuit voltage and 8/20 µs short circuit current). Circuit specified generators usually equate to a combination generator, although typically only the open circuit voltage waveshape is referenced (e.g. a 10/700 µs open circuit voltage generator typically produces a 5/310 µs short circuit current). If the combination or circuit defined generators operate into a finite resistance the wave shape produced is intermediate between the open circuit and short circuit values.

# current rating

When the TISP switches into the on-state it has a very low impedance. As a result, although the surge wave shape may be defined in terms of open circuit voltage, it is the current wave shape that must be used to assess the required TISP surge capability. As an example, the CCITT IX K17 1.5 kV, 10/700 µs surge is changed to a 38 A, 5/310 µs waveshape when driving into a short circuit. Thus the TISP surge current capability, where directly connected to the generator, will be found for the CCITT IX K17 waveform at 310 µs on the surge graph and not 700 µs. Some common short circuit equivalents are tabulated below:

STANDARD	OPEN CIRCUIT VOLTAGE	SHORT CIRCUIT CURRENT
CCITT IX K17	1.5 kV, 10/700 µs	38 A, 5/310 µs
CCITT IX K20	1 kV, 10/700 µs	25 A, 5/310 us
FILM88	1.5 kV, 0.5/700 µs	38 A, 0.2/310 µs
VDE 0433	2.0 kV, 10/700 µs	50 A, 5/200 µs
FTZ R12	2.0 kV, 10/700 µs	50 A, 5/310 µs

Any series resistance in the protected equipment will reduce the peak circuit current to less than the generators' short circuit value. A 2 kV open circuit voltage, 50 A short circuit current generator has an effective output impedance of 40  $\Omega$  (2000/50). If the equipment has a series resistance of 25  $\Omega$  then the surge current requirement of the TISP becomes 31 A (2000/65) and not 50 A.



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# **APPLICATIONS INFORMATION**

# protection voltage

The protection voltage,  $(V_{(BO)})$ , increases under lightning surge conditions due to thyristor regeneration. This increase is dependent on the rate of current rise, didt, when the TISP is clamping the voltage in its breakdown region. The  $V_{(BO)}$  value under surge conditions can be estimated by multiplying the 50 Hz rate  $V_{(BO)}$  (250 V/ms) value by the normalised increase at the surge's didt (Figure 12.). An estimate of the di/dt can be made from the surge generator voltage rate of rise, dv/dt, and the circuit resistance.

As an example, the CCITT IX K17 1.5 kV, 10/700  $\mu$ s surge has an average dv/dt of 150 V/ $\mu$ s, but, as the rise is exponential, the initial dv/dt is higher, being in the region of 450 V/ $\mu$ s. The instantaneous generator output resistance is 25  $\Omega$ . If the equipment has an additional series resistance of 20  $\Omega$ , the total series resistance becomes 45  $\Omega$ . The maximum di/dt then can be estimated as 450/45 = 10 A/ $\mu$ s. In practice the measured dV/dt and protection voltage increase will be lower due to inductive effects and the finite slope resistance of the TISP breakdown region.

# capacitance

# off-state capacitance

The off-state capacitance of a TISP is sensitive to junction temperature,  $T_J$ , and the bias voltage, comprising of the dc voltage,  $V_D$ , and the ac voltage,  $V_d$ . All the capacitance values in this data sheet are measured with an ac voltage of 100 mV. The typical 25°C variation of capacitance value with ac bias is shown in Figure 17. When  $V_D >> V_d$  the capacitance value is independent on the value of  $V_d$ . The capacitance is essentially constant over the range of normal telecommunication frequencies.

### NORMALISED CAPACITANCE

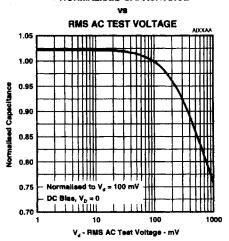


Figure 17.

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# **APPLICATIONS INFORMATION**

# longitudinal balance

Figure 18 shows a three terminal TISP with its equivalent "delta" capacitance. Each capacitance,  $C_{TG}$ ,  $C_{RG}$  and  $C_{TR}$ , is the true terminal peir capacitance measured with a three terminal or guarded capacitance bridge. If wire R is biased at a larger potential than wire T then  $C_{TG} > C_{RG}$ . Capacitance  $C_{TG}$  is equivalent to a capacitance of  $C_{RG}$  in parallel with the capacitive difference of  $(C_{TG} - C_{RG})$ . The line capacitive unbalance is due to  $(C_{TG} - C_{RG})$  and the capacitance shunting the line is  $C_{TR} + C_{RG}/2$ .

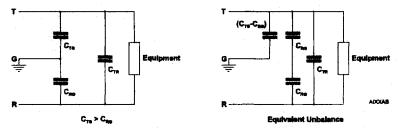


Figure 18.

All capacitance measurements in this data sheet are three terminal guarded to allow the designer to accurately assess capacitive unbalance effects. Simple two terminal capacitance meters (unguarded third terminal) give false readings as the shunt capacitance via the third terminal is included.